

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

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- 1 Claim 1 (Original): An electrical test probe tip, comprising:
- 2 (a) a conductive flexible coil having a first end and a second end;
- 3 (b) said first end for coupling with a device to be probed; and
- 4 (c) a connector attached to said second end of said conductive flexible
- 5 coil.
- Bl 1 Claim 2 (Original): The electrical test probe tip of claim 1, said connector
- 2 being a connecting pin coupleable to a probing head.
- 1 Claim 3 (Original): The electrical test probe tip of claim 1, said connector
- 2 being a square pin coupleable to a probing head.
- 1 Claim 4 (Withdrawn):
- 1 Claim 5 (Original): The electrical test probe tip of claim 1, said flexible coil
- 2 having a longitudinal axis and a first diameter, said first diameter being substantially
- 3 equal throughout said longitudinal axis of said flexible coil.
- 1 Claim 6-12 (Withdrawn):
- 1 Claim 13 (Original): A multipurpose electrical test probe tip, comprising:
- 2 (a) a conductive flexible member;
- 3 (b) said flexible member having a first end and a second end;

4 (c) said flexible member being substantially hollow at said first end;
5 and

6 (d) said first end of said conductive flexible member for flexibly
7 coupling with a component to be probed.

1 Claim 14 (Original): The multipurpose electrical test probe tip of claim 13,
2 wherein said second end of said conductive flexible member is interconnectable with a
3 probing head.

1 Claim 15 (Withdrawn):

1 Claim 16 (Original): The multipurpose electrical test probe tip of claim 14,
2 said second end of said conductive flexible member further comprising a connector
3 coupleable with said probing head.

1 Claim 17 (Original): The multipurpose electrical test probe tip of claim 13,
2 said flexible member having a longitudinal axis and a first diameter, said first diameter
3 being substantially equal throughout said longitudinal axis of said flexible coil.

1 Claim 18-27 (Withdrawn):

1 Claim 28 (New): The electrical test probe tip of claim 1, said conductive
2 flexible coil being substantially hollow at said first end.

1 Claim 29 (New): The electrical test probe tip of claim 1, said conductive
2 flexible coil being substantially hollow.

1 Claim 30 (New): The electrical test probe tip of claim 1, said first end of
2 said conductive flexible coil being suitable to receive a device to be probed therein.

1 Claim 31 (New): The electrical test probe tip of claim 1, wherein said first
2 end of said conductive flexible coil at least partially surrounds a device to be probed.

1 Claim 32 (New): The multipurpose electrical test probe tip of claim 13,
2 said conductive flexible member being substantially hollow.

1 Claim 33 (New): The multipurpose electrical test probe tip of claim 13,
2 said first end of said conductive flexible member being suitable to receive a component
3 to be probed therein.

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1 Claim 34 (New): The multipurpose electrical test probe tip of claim 13,
2 wherein said first end of said conductive flexible member at least partially surrounds a
3 component to be probed.
